

ADVANCED CHARTING TECHNIQUE FOR QUALITY CONTROL

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ABSTRACT

An advanced process state testing technique is described. It combines the Neyman - Person Approach to Statistical Analysis and the Taguchi Loss Function Approach to Quality Assessment. The technique results in significant reduction of the risk of adjustment errors compared with conventional (Shewhart charts) method. A software module supporting the suggested technique is available as, an option, considerably increasing the efficiency of the automated process control by feedback adjustment.

INTRODUCTION

There are many quality improvement tools, used in manufacturing practice. All these tools, except the control chart, represent the so-called 'static' instruments, i.e. they do not yield information in real time. Therefore, 'the tool most generally recommended to controlling the quality during the course of their actual manufacturing is the control chart' - Feigenbaum (1983).

The chart suggested by W. Shewhart (1931) involves charting results of repeated sampling on a vertical scale against the sample number, plotted horizontally. The sample statistic may be: average, median, range, standard deviation, etc., if a process is judged by variables, number of defectives, proportion of defectives, number of defects, etc., if a process is judged by attributes.

The statistic values should cluster about a central line, which represents either a specified standard or the statistic long-term average of the process. The upper and lower chart limits (UCL and LCL, respectively) represent the boundaries of typical statistic variation (so-called 'inherent variability') due to random fluctuations, which are inevitable and allowable. If during the course of production a statistic value from one of the samples is recorded outside the limits, it would be concluded that a change in the process had occurred and it would immediately be investigated to determine a cause of the change. In this way many poor production practices have been corrected before the production of large number of defective units. A typical control chart is shown in Fig. 1.

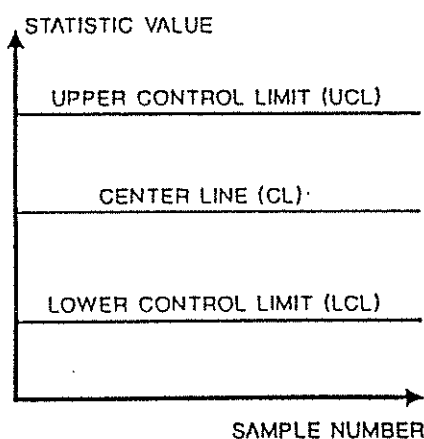


Figure 1. Typical Control Chart

Statistical Behavior

Variables control charts, i.e. so-called 'classical Shewhart charts', solve the problem of process testing by separate assessment of the measures of central tendency and spread. Common practice implies setting up the chart averages (\bar{x}) and the chart based on either the sample range (R) or the sample standard deviation (s). This technique is equivalent to construction of a rectangular control region (Shewhart Rectangle) on a two-dimensional plot formed by superimposing the charts. This Rectangle represents boundary of Shewhart control region and is used for testing the Dual Null-Hypothesis concerning the process stability:

$$H_0: \sigma = \sigma_0 \text{ and } \mu = \mu_0$$

$$H_1: \sigma \neq \sigma_0 \text{ or } \mu \neq \mu_0$$

where σ and μ represent process spread and central tendency estimated by the sample statistics; σ_0 and μ_0 are characterized by the chart centerlines. For all sample points ($\bar{x}_i; s_i$) falling within the Rectangle the process is considered to be in a state of control, otherwise it is in 'out-of-control' state in terms of process mean or variability (p. 2).

AVERAGE

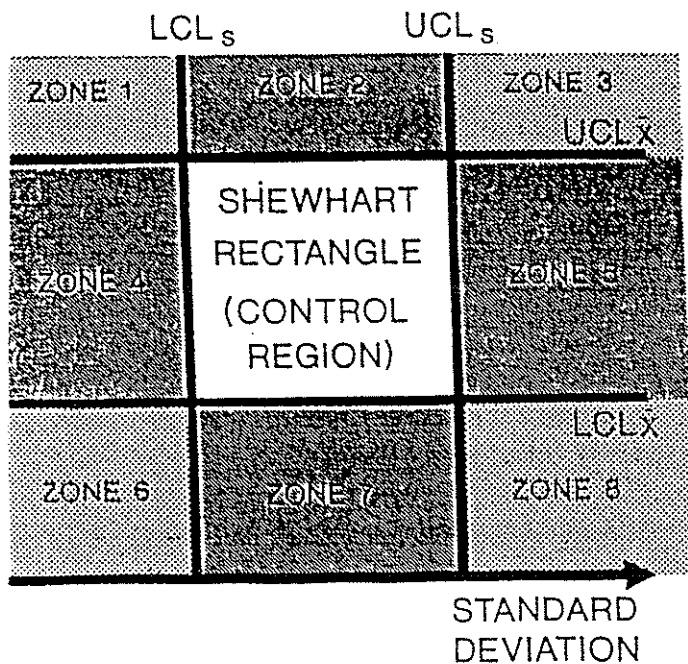


Figure 2. Shewhart Decision Making Method

In contrast to the Shewhart decision making method this work is based on the Neyman-Pearson (1928) approach to process testing discussed in their paper preceding the famous Shewhart (1931) publication. Neyman and Pearson showed that for the case of simultaneously controlled process mean and variability the control region has an oval shape and represents the results of cutting the joint sampling distribution by a horizontal plane at the height corresponding to the given significance level. Fig.3 presents the Shewhart Rectangle and the oval as well as the results of sampling (set of 25,000 samples, n=5) from a process with normal random variation N(0;1). One can see that the oval much better fits the shape of the scatter diagram, so the Rectangle represents the rather rough approximation of the true control region.

The oval-shaped control region inevitably leads to rejection of the conception of constant control limits on control charts. Choosing the sample standard deviation as a basis for follow-up analysis, one can set up the chart

averages with variable control limits depending on the s-value. Obviously, the dependence corresponds to the variation of the oval and the limits dynamics reflect the standard deviation fluctuations. The interested reader can find the detailed description of the method theory in our paper (see Bluyband and Grabov (1995)) presented at the 1995 ASQC Annual Quality Congress.

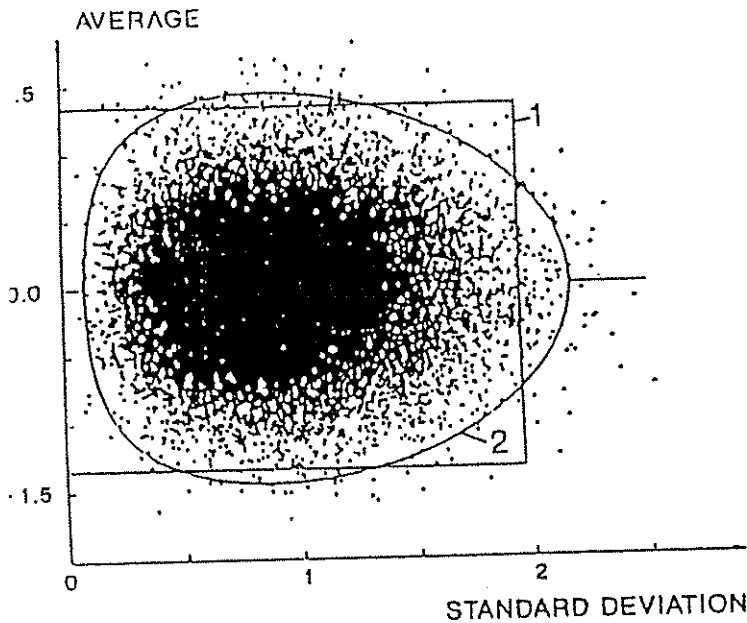


Figure 3. \bar{X} -S Graph presenting the Results of Monte-Carlo simulation:
1 - shewhart Rectangle, Z - B - over, sampling Data

2 Current Quality Evaluation

Stability evaluation is interesting for manufacturer, whereas what counts for the customers is whether the process quality is stable. Therefore, complete continuous process analysis include a feature for on-line quality monitoring. For current quality evaluation we proposed a loss estimator (LE-statistic) closely resembling the Taguchi Expected Loss for a normally distributed product characteristic. On the assumption that samples of size n are drawn from a normal universe with parameters μ and σ , the LE-statistic is given by

$$LE_i = \frac{1}{n} \sum_{j=1}^n (x_{ji} - \mu)^2 \quad \sigma^2 \left[\frac{n-2}{n} (s_i^*)^2 + (\bar{z}_i)^2 \right]$$

where x_{ji} denotes the j -th reading of the i -th sample,

$$\bar{z} = \frac{\bar{X} - \mu}{\sigma}; \quad s = \frac{s}{\sigma} \sqrt{\frac{n-1}{n-2}}$$

Thus the LE-statistic value depends on both unit-to-unit variation and process deterioration (wear-out, shift, etc.). The main difference between the LE-estimator and the Expected Loss, is that the former characterizes the on-line quality activity and uses the sample statistic for current loss evaluation. The latter characterizes the off-line quality activity and is associated with the loss computed via the population parameters.

The control limit for the LE-statistic can be established from the extreme loss under process random statistical behavior. Comparison of the losses due to inherent process variability shows that the extreme loss value corresponds to the right vertex of the oval with the coordinates $\bar{z} = 0$ and s^* .

Thus the 'loss control region' on the \bar{x} -s graph is bounded by the iso-loss semiellipse given by

$$\frac{n-2}{n} (s^*)^2 + (\bar{z})^2 \leq \frac{n-2}{n} (s^*)^2 \quad (2)$$

and shown in Fig. 4 From Eq. (2) one can easily get the expression for the quality control limits on the \bar{x} -chart as a function of the sample standard deviation.

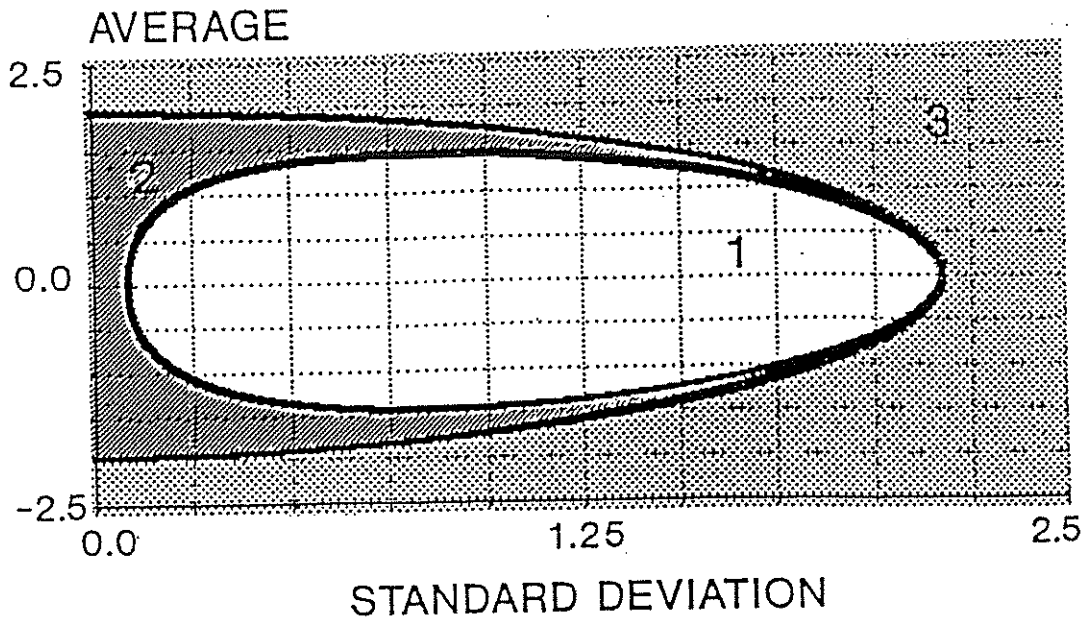


Figure 4. The Area under \bar{x} -s Graph Subdivided by the B - Oval and the Iso - Loss Semiellipse

- 1 - In - Control State
- 2 - Warning State
- 3 - Out - Of - Control State

3. COMPLETE PROCESS ANALYSIS

Combining two couples of variability limits (for stability testing and for quality assessment) on the same chart of averages one can set up a pooled chart intended for complete process analysis. Since the semiellipse contains the oval touching it only at the right vertex, the couple of quality control limits will be outer in relation to the inner couple of stability limits for all sample standard deviation values smaller than the right vertex of the oval. The pooled chart represents a tool for simultaneous visualization of the process central tendency (\bar{x} -plot) and spread (control limits) variation.

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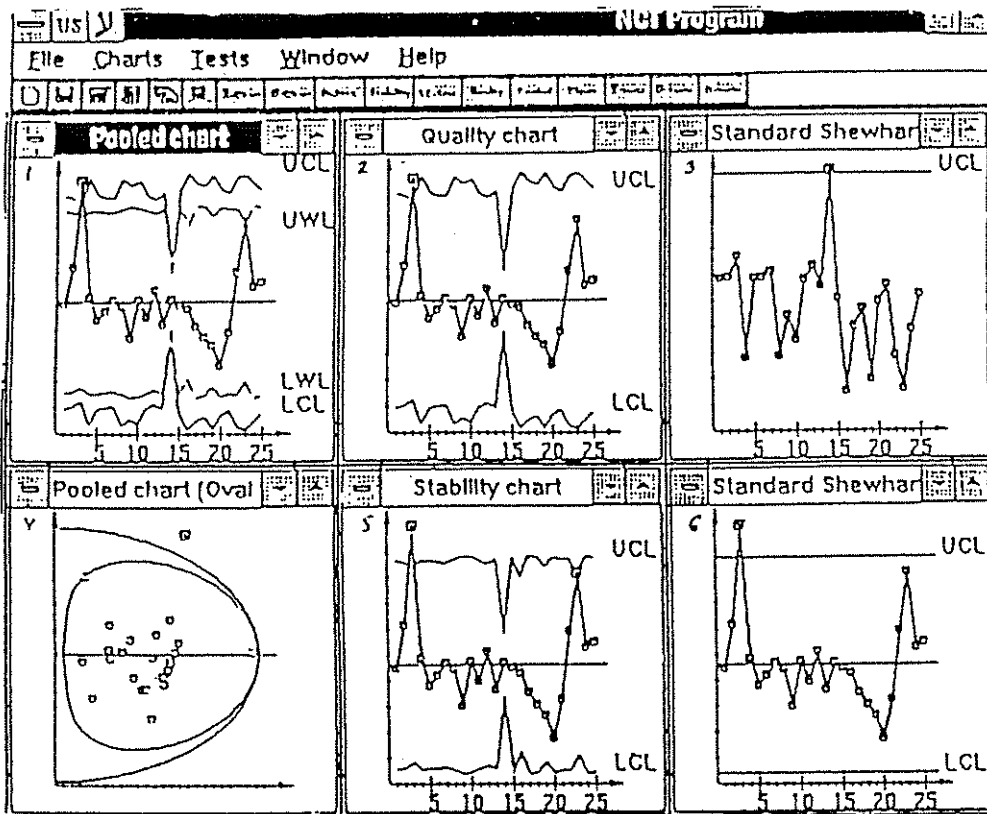


Figure 6. Screens of the Program Supporting the Suggested Approach: 1 - Pooled Chart, 2 - Quality Chart, 3 - Shewhart S - chart, 4 - \bar{x} -s Graph, 5 - Stability Chart, 6 Shewart \bar{x} - Chart

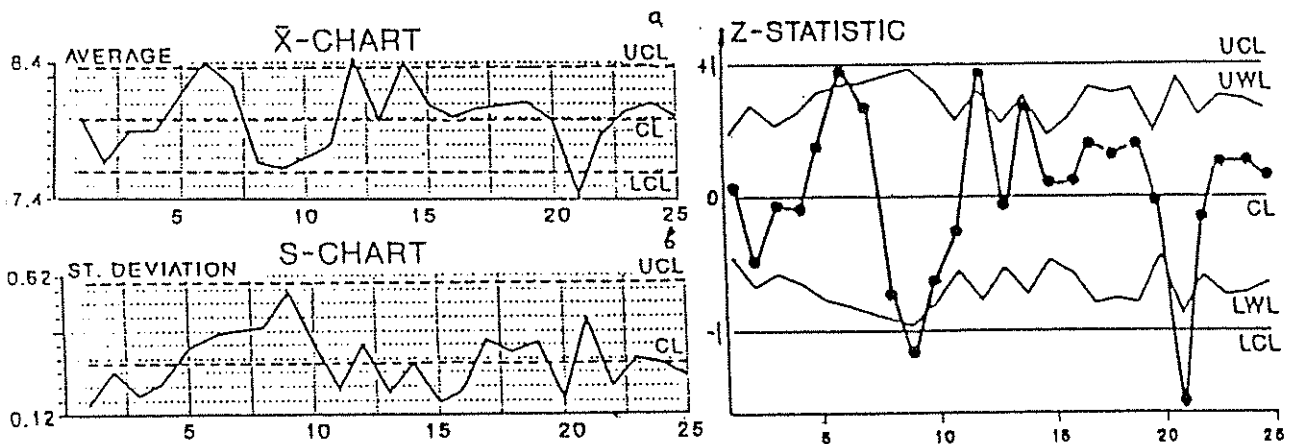


Figure 7. Case Study: a - \bar{x} Chart, b - S. Chart, c - Standardized Pooled Chart

SUMMARY

Despite the fact that customer requirements are the driving force in today's world, the standard charting technique is oriented only to the evaluation of process statistical behavior over time. This problem has significance for the producer, and not to the customer, who is interested only in the fact that the product quality is stable.

The proposed advanced technique presents a new tool (pooled chart) for Quality - Oriented SPC. Extending the Taguchi Approach activity for on-line quality control, the approach claims that it is unprofitable to adjust a process characterized by quality loss which does not exceed the extreme limit under random statistical behavior (due to process inherent variability). The proposed quality-oriented pooled chart represents a graphical mean for detecting variability from the quality to be expected in a continuous production line and indicate when a process should be examined for trouble. Actually, the chart is intended for performing the test of the hypothesis that subsequently produced items have essentially the same Quality Characteristics as previously produced ones.

Both setting up and analysis of the pooled chart could be simplified by its normalization, i.e. by producing a standardized chart with zero centerline, the constant (± 1) outer control limits (for quality assessment) and the variable inner ones (for stability testing). The plotting normalized statistic is given by:

$$z_1 = \left[(s_1^*)^2 - \frac{n}{n-2} (\bar{z}_1)^2 \right] \frac{\text{sign}(\bar{x}_1 - \bar{\bar{x}})}{(s_{1v}^*)^2} \quad (3)$$

The suggested technique allows also to perform correct diagnostics of the assignable causes of the process 'out-of-control' state. The Shewhart concept of subdivision of the area under the \bar{x} -s graph into 9 different zones (Shewhart Rectangle and 8 'out-of control' zones - see Fig. 2) is logical and is accepted for our approach as well. In contrast compared with the Rectangle the zone boundaries represent the curves of the gradients perpendicular to the oval contour of the control region (see Fig. 5) The gradient equations represent the line of the "steepest descent" to the control region and should be used for optimization of the feedback controllers used for automated process control in conjunction with the control charts.

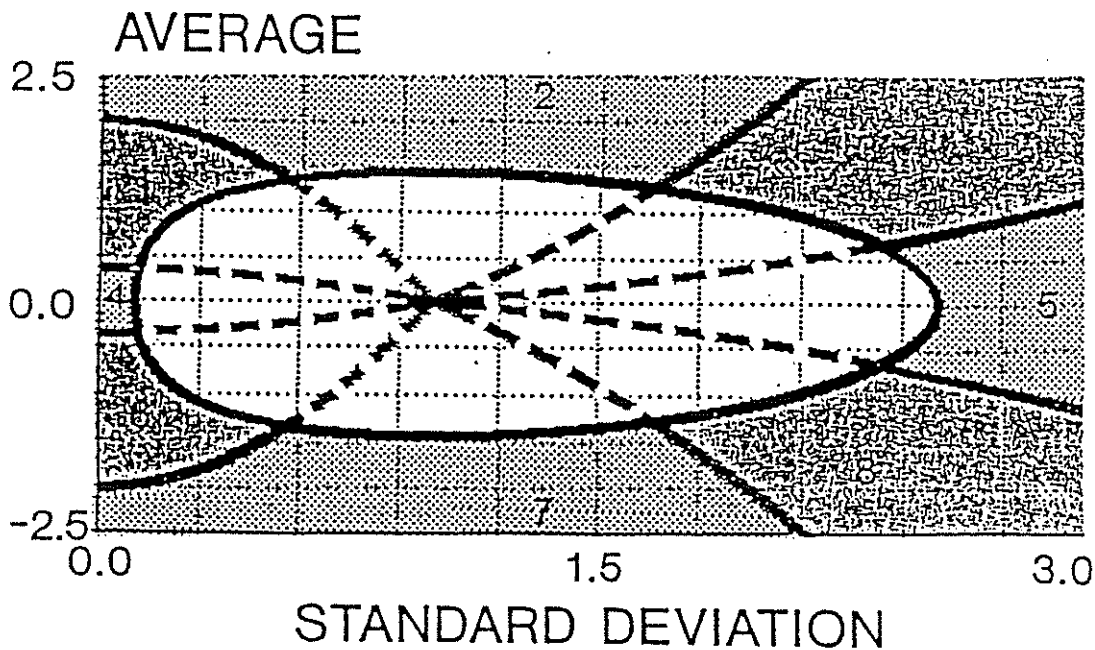


Figure 5. Decision Mapping In the Oval Control Region

The proposed technique is somewhat more complex than the Shewhart charts. However, with the advance of automated data collection and computerized data analysis the complexity factor is rather insignificant. The end user need not be overwhelmed by any charting mathematics, as a suitable program performs the statistical calculations and displays the control chart on a monitor. Some screens of the program supporting the suggested approach are shown in Fig. 6. The program is intended for current process control by collecting data, their treatment and analysis as well as for reporting information. The program also generates signals for controllers maintaining product properties at their target values.

CASE STUDY

The viscosity of the first 25 samples of six was measured during the start-up phase of a new chemical process. The samples were used to set up the Shewhart \bar{x} - and s-charts as well as the standardized pooled chart shown in Fig. 7. Comparative analysis of the conventional and proposed approaches leads to a conclusion, that the process management according to the Shewhart charts leads to some adjustment errors: overadjustment - 3 points, underadjustment - 1 point.